# **MOSFET** – Power, N-Channel, UltraFET

75 V, 150 A, 0,016  $\Omega$ 

## **HUFA75852G3-F085**

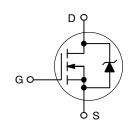
#### **Features**

- Ultra Low On-Resistance
  - $-R_{DS(ON)} = 0.016 \Omega$ ,  $V_{GS} = 10 V$
- Peak Current vs Pulse Width Curve
- UIS Rating Curve
- AEC-Q101 Qualified and PPAP Capable
- This Device is Pb-Free and is RoHS Compliant



#### ON Semiconductor®

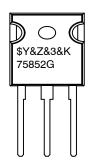
#### www.onsemi.com





JEDEC TO-247 CASE 340CK

#### MARKING DIAGRAM



- \$Y = ON Semiconductor Logo &Z = Assembly Plant Code
- &Z = Assembly Plant Code &3 = Data Code (Year & Week)
- &K = Lot
- 75852G = Specific Device Code

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

#### ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C, Unless otherwise noted)

Symbol		Parameter	Value	Unit
V <sub>DSS</sub>	Drain to Source Voltage (N	Drain to Source Voltage (Note 1)		
$V_{DGR}$	Gate to Gate Voltage (R <sub>GS</sub>	150	V	
$V_{GS}$	Gate to Source Voltage	±20	V	
I <sub>D</sub>	Drain Current Continuous	75	Α	
	Drain Current Continuous (T <sub>C</sub> = 100°C, V <sub>GS</sub> = 10 V) (Figure 2)		75	Α
I <sub>DM</sub>	Pulsed Drain Current		Figure 4	
UIS	Pulsed Avalanche Rating		Figures 6, 14, 15	
$P_{D}$	Power Dissipation	(T <sub>C</sub> = 25°C)	500	W
		- Derate Above 25°C	3.33	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Ter	Operating and Storage Temperature		°C
TL	Maximum Temperature	Leads at 0.063 in (1.6 mm) from Case for 10 s	300	°C
T <sub>pkg</sub>	for Soldering	Package Body for 10 s	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Starting T<sub>J</sub> = 25°C to 150°C.

#### PACKAGE MARKING AND ORDERING INFORMATION

Part Number		Package	Brand	
	HUFA75852G3-F085	TO-247	75852G	

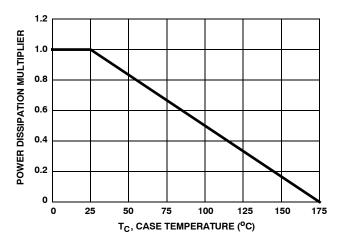
### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Co	nditions	Min.	Тур.	Max.	Unit
OFF STATE CH	HARACTERISTICS			•			
B <sub>VDSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> =	0 V (Figure 11)	150			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 140 V, V <sub>GS</sub> = 0 V				1	μΑ
		V <sub>DS</sub> = 135 V, V <sub>GS</sub> =	= 0 V, T <sub>C</sub> = 150°C			250	
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V				±100	nA
ON STATE CH	ARACTERISTICS	•		1	•		
V <sub>GS(TH)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 25$	0 μA (Figure 10)	2.0		4.0	V
R <sub>DS(ON)</sub>	Drain to Source On Resistance	I <sub>D</sub> = 75 A, V <sub>GS</sub> = 10	V (Figure 9)		0.013	0.016	Ω
THERMAL CH	ARACTERISTICS	•		1	•		
$R_{ heta JC}$	Thermal Resistance Junction to Case	TO-247				0.30	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient					30	°C/W
SWITCHING C	HARACTERISTICS			I			
t <sub>on</sub>	Turn-On Time	V <sub>DD</sub> = 75 V				260	ns
t <sub>d(on)</sub>	Turn-On Delay Time	l <sub>D</sub> = 75 A V <sub>GS</sub> = 10 V			22		ns
t <sub>r</sub>	Rise Time	$R_{GS} = 2.0 \Omega$ (Figures 18, 19)			151		ns
t <sub>d(off)</sub>	Turn-Off Delay Time				82		ns
t <sub>f</sub>	Fall Time				107		ns
t <sub>off</sub>	Turn-Off Time					285	ns
GATE CHARG	E CHARACTERISTICS			1	•		
Q <sub>g(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 0 V to 20 V	V <sub>DD</sub> = 75 V		400	480	nC
Q <sub>g(10)</sub>	Total Gate Charge 10 V	V <sub>GS</sub> = 0 V to 10 V	I <sub>D</sub> = 75 A I <sub>g(REF)</sub> = 1.0 mA	,	215	260	nC
Q <sub>g(TH)</sub>	Threshold Gate Charge	V <sub>GS</sub> = 0 V to 2 V	(Figures 13,16,17)		15	17.5	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	V <sub>DD</sub> = 75 V, I <sub>D</sub> = 75	A .		25		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	$I_{g(REF)} = 1.0 \text{ mA}, (F)$	Figures 13,16, 17)		66		nC
CAPACITANCE	E CHARACTERISTICS			•			
C <sub>ISS</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ (Figure 12)			7690		pF
C <sub>OSS</sub>	Output Capacitance				1650		pF
C <sub>RSS</sub>	Reverse Transfer Capacitance				535		pF
SOURCE TO D	PRAIN DIODE CHARACTERISTICS						
V <sub>SD</sub>	Source to Drain Diode Voltage	I <sub>SD</sub> = 75 A				1.25	V
		I <sub>SD</sub> = 35 A				1.00	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> = 75 A, dI <sub>SD</sub> /dt = 100 A/μs				260	ns
Q <sub>rr</sub>	Reverse Recovery Charge					1830	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**

 $(T_C = 25^{\circ}C \text{ unless otherwise noted})$ 



80 V<sub>GS</sub> = 10V V<sub>GS</sub> = 10V V<sub>GS</sub> = 10V V<sub>GS</sub> = 10V T<sub>C</sub>, CASE TEMPERATURE (°C)

Figure 1. Normalized Power Dissipation vs. Case Temperature

Figure 2. Maximum Continuous Drain Current vs Case Temperature

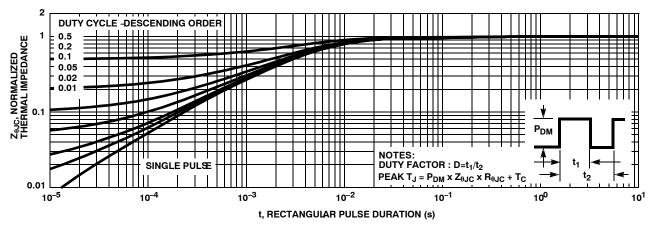


Figure 3. Normalized Maximum Transient Thermal Impedance

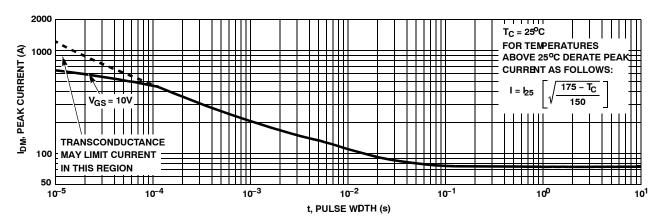


Figure 4. Peak Current Capability

#### TYPICAL CHARACTERISTICS (Continued)

 $T_C = 25^{\circ}C$  unless otherwise noted

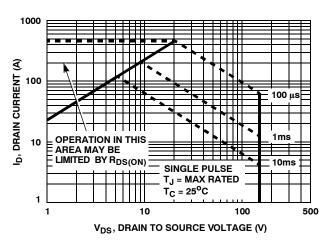


Figure 5. Forward Bias Safe Operating Area

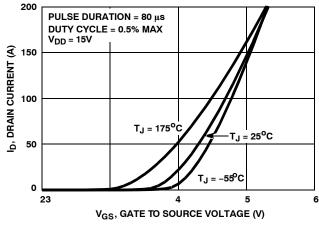


Figure 7. Transfer Characteristics

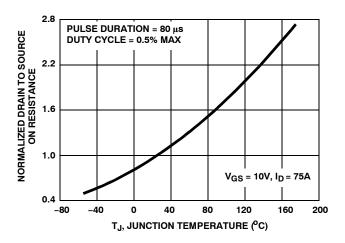


Figure 9. Normalized Drain to Source On Resistance vs Junction Temperature

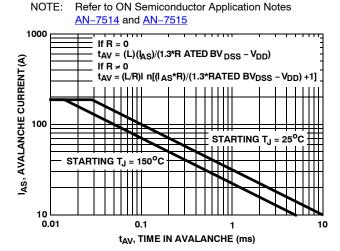


Figure 6. Unclamped Inductive Switching Capability

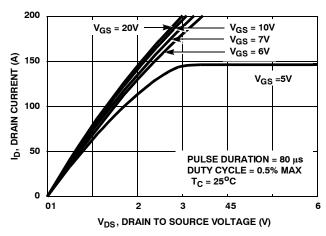


Figure 8. Saturation Characteristics

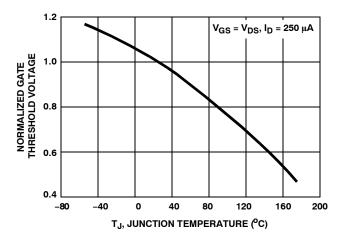


Figure 10. Normalized Gate Threshold Voltage vs Junction Temperature

#### TYPICAL CHARACTERISTICS (Continued)

(T<sub>C</sub> = 25°C unless otherwise noted)

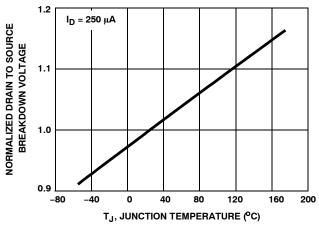


Figure 11. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

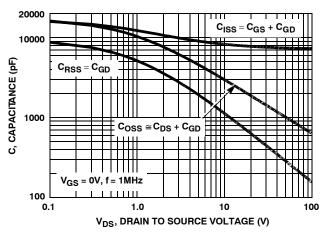


Figure 12. Capacitance vs. Drain to Source Voltage

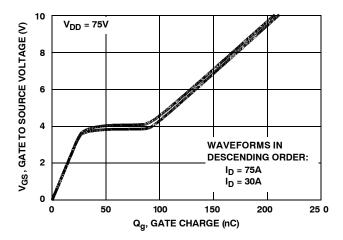


Figure 13. Gate Charge Waveforms for Constant Gate Current

#### **TEST CIRCUITS AND WAVEFORMS**

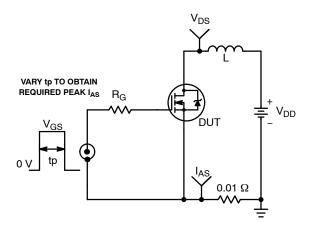


Figure 14. Unclamped Energy Test Curcuit

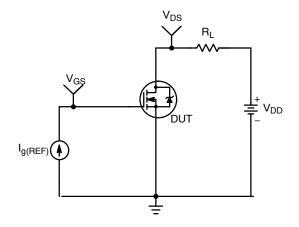


Figure 16. Gate Charge Test Circuit

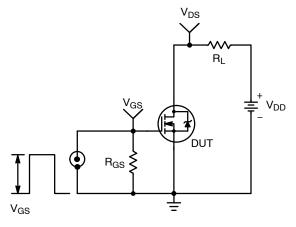


Figure 18. Switching Time Test Circuit

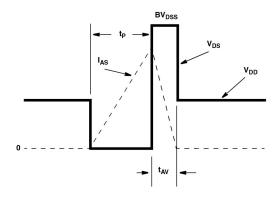


Figure 15. Unclamped Energy Waveforms

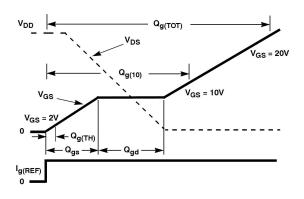


Figure 17. Gate Charge Waveforms

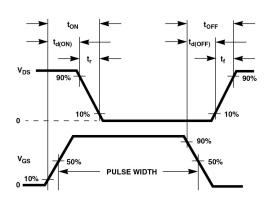
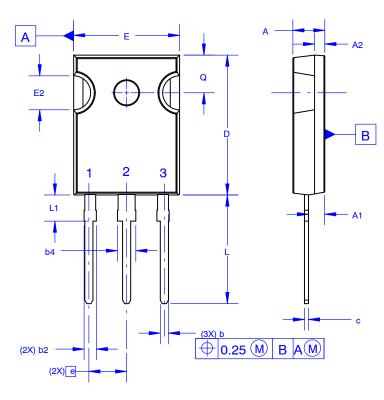


Figure 19. Switching Time Waveforms



#### TO-247-3LD SHORT LEAD

CASE 340CK ISSUE A



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code

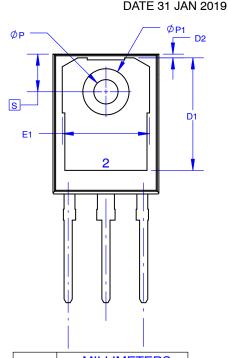
A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



DIM	MILLIMETERS				
וווט	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D	20.32	20.57	20.82		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
Е	15.37	15.62	15.87		
E1	12.81	~	~		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	15.75	16.00	16.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
Ø <b>P1</b>	6.60	6.80	7.00		
Ø	5.34	5.46	5.58		
S	5.34	5.46	5.58		

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DESCRIPTION:	TO-247-3LD SHORT LEAD		PAGE 1 OF 1	

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